

# LOW SKEW CMOS PLL CLOCK DRIVER WITH INTEGRATED LOOP FILTER

QS5919

### **FEATURES:**

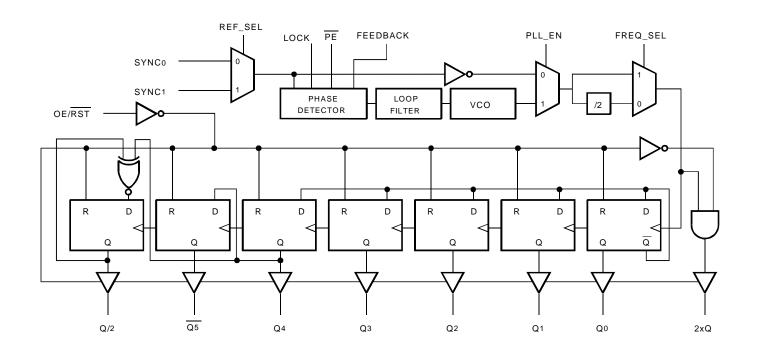
- 5V operation
- Low noise CMOS level outputs
- < 500ps output skew, Q0–Q4</li>
- 2xQ output, Q outputs, Q output, Q/2 output
- Outputs 3-state and reset while OE/RST low
- PLL disable feature for low frequency testing
- Internal loop filter RC network
- Functional equivalent to Motorola MC88915
- Positive or negative edge synchronization (PE)
- Balanced drive outputs ±36mA
- 160MHz maximum frequency (2xQ output)
- Available in QSOP and PLCC packages

### **DESCRIPTION**

The QS5919 Clock Driver uses an internal phase locked loop (PLL) to lock low skew outputs to one of two reference clock inputs. Eight outputs are available: 2xQ, Q0-Q4,  $\overline{Q5}$ , Q/2. Careful layout and design ensure < 500ps skew between the Q0-Q4, and Q/2 outputs. The QS5919 includes an internal RC filter which provides excellent jitter characteristics and eliminates the need for external components. Various combinations of feedback and a divide-by-2 in the VCO path allow applications to be customized for linear VCO operation over a wide range of input SYNC frequencies. The PLL can also be disabled by the PLL\_EN signal to allow low frequency or DC testing. The LOCK output asserts to indicate when phase lock has been achieved. The QS5919 is designed for use in high-performance workstations, multi-board computers, networking hardware, and mainframe systems. Several can be used in parallel or scattered throughout a system for guaranteed low skew, system-wide clock distribution networks.

For more information on PLL clock driver products, see Application Note AN-227.

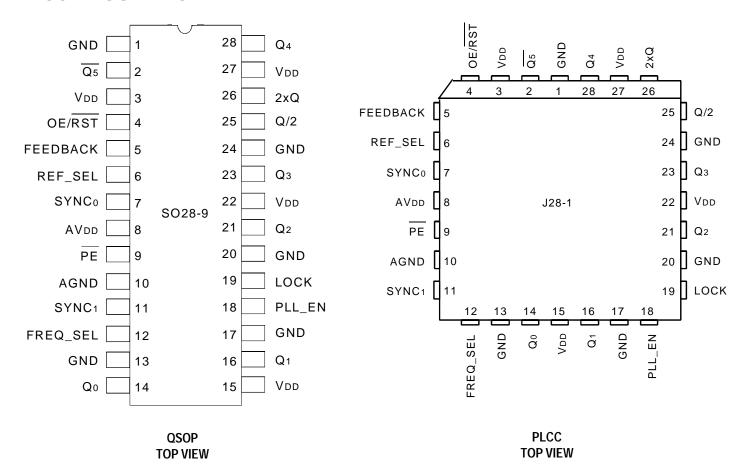
# **FUNCTIONAL BLOCK DIAGRAM**



INDUSTRIAL TEMPERATURE RANGE

**JULY 2000** 

# **PIN CONFIGURATION**



# **ABSOLUTE MAXIMUM RATINGS (1)**

Symbol	Rating	Max.	Unit	
AVDD/VDD	Supply Voltage to Ground	-0.5 to +7	٧	
VIN	DC Input Voltage VIN	-0.5 to +7	V	
	Maximum Power QSOP Dissipation (TA = 85°C) PLCC		655	mW
			770	mW
Tstg	Storage Temperature Range		-65 to +150	°C

# NOTE:

 Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

# **CAPACITANCE** (T<sub>A</sub> = 25° C, f = 1MHz, V<sub>IN</sub> = 0V)

	QSOP		PLCC		
Parameter	Тур.	Max.	Тур.	Max.	Unit
CIN	3	4	4	6	pF

# **PIN DESCRIPTION**

Pin Name	I/O	Description
SYNC <sub>0</sub>	I	Reference clock input
SYNC1	I	Reference clock input
REF_SEL	I	Reference clock select. When 1, selects SYNC1. When 0, selects SYNC0.
FREQ_SEL	I	VCO frequency select. For choosing optimal VCO operating frequency depending on input frequency.
FEEDBACK	I	PLL feedback input which is connected to a user selected output pin. External feedback provides flexibility for different output frequency relationships. See the Frequency Selection Table for more information.
Q0 -Q4	0	Clock outputs
Q <sub>5</sub>	0	Clock output. Matched in frequency, but inverted with respect to Q.
2xQ	0	Clock output. Matched in phase, but frequency is double the Q frequency.
Q/2	0	Clock output. Matched in phase, but frequency is half the Q frequency.
LOCK	0	PLL lock indication signal. 1 indicates positive lock. 0 indicates that the PLL is not locked and outputs may not be synchronized to the inputs.
OE/RST	I	Output enable/asynchronous reset. Resets all output registers. When 0, all outputs are held in a tri-stated condition. When 1, outputs are enabled.
PLL_EN	I	PLL enable. Enables and disables the PLL. Useful for testing purposes.
PE	I	When $\overline{PE}$ is LOW, outputs are synchronized with the positive edge of SYNC. When HIGH, outputs are synchronized with the negative edge of SYNC.
V <sub>DD</sub>	_	Power supply for output buffers.
AVDD	_	Power supply for phase lock loop and other internal circuitries.
GND	_	Ground supply for output buffers.
AGND	_	Ground supply for phase lock loop and other internal circuitries.

# **OUTPUT FREQUENCY SPECIFICATIONS**

Industrial: TA = -40°C to +85°C, AVDD/VDD = 5.0V  $\pm$  10%

Symbol	Description	- 55	- 70	- 100	- 133	- 160	Units
FMAX_2XQ	Max Frequency, 2xQ	55	70	100	133	160	MHz
FMAX_Q	Max Frequency, Qo - Q4, Q5	27.5	35	50	66.5	80	MHz
FMAX_Q/2	Max Frequency, Q/2	13.75	17.5	25	33.25	40	MHz
FMIN_2XQ	Min Frequency, 2xQ	20	20	20	20	20	MHz
FMIN_Q	Min Frequency, Qo - Q4, Q5	10	10	10	10	10	MHz
FMIN_Q/2	Min Frequency, Q/2	5	5	5	5	5	MHz

# FREQUENCY SELECTION TABLE

	Output Used for	SYNC (MHz) (allowable range) (1)			Output Frequency	y Relationships (2)	
FREQ_SEL	Feedback	Min.	Max	Q/2	Q <sub>5</sub>	Q0 - Q4	2XQ
HIGH	Q/2	FMIN_Q/2	FMAX _Q/2	SYNC	- SYNC X 2	SYNC X 2	SYNC X 4
HIGH	Q <sub>0</sub> -Q <sub>4</sub>	FMIN_Q	FMAX_Q	SYNC / 2	- SYNC	SYNC	SYNC X 2
HIGH	Q <sub>5</sub>	FMIN_Q	FMAX_Q	- SYNC / 2	SYNC	- SYNC	- SYNC X 2
HIGH	2xQ	FMIN_2XQ	FMAX _2XQ	SYNC / 4	- SYNC / 2	SYNC/2	SYNC
LOW	Q/2	FMIN_Q/2 /2	FMAX _Q/2 /2	SYNC	- SYNC X 2	SYNC X 2	SYNC X 4
LOW	Q0 -Q4	FMIN_Q /2	FMAX _Q /2	SYNC / 2	- SYNC	SYNC	SYNC X 2
LOW	$\overline{\mathrm{Q}_5}$	FMIN_Q /2	FMAX_Q /2	- SYNC / 2	SYNC	- SYNC	- SYNC X 2
LOW	2xQ	FMIN_2XQ /2	FMAX _2XQ /2	SYNC / 4	- SYNC / 2	SYNC/2	SYNC

#### NOTES:

## DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified: Industrial:  $T_A = -40^{\circ} \text{C to } +85^{\circ} \text{C}$ ,  $AV_{DD}/V_{DD} = 5.0V \pm 10\%$ 

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
VIH	Input HIGH Voltage	Guaranteed Logic HIGH Level	2	_	_	V
VIL	Input LOW Voltage	Guaranteed Logic LOW Level	_	_	0.8	V
Vон	Output HIGH Voltage	Iон = −36mA	VDD - 0.75	_	_	V
		Іон = —100µA	V <sub>DD</sub> – 0.2	_	_	V
Vol	Output LOW Voltage	VDD = Min., IOL = 36mA	_	_	0.45	V
		VDD = Min., IOL = 100μA	_	_	0.2	V
VH	Input Hysteresis	_	_	100	_	mV
loz	Output Leakage Current	Vout = Vdd or GND, Vdd = Max.	_	_	5	μΑ
lin	Input Leakage Current	VIN = AVDD or GND, AVDD = Max.	_	_	5	μΑ
IPD	Input Pull-Down Current (PE)	AVDD = Max., VIN = AVDD	_	_	100	μΑ

# **POWER SUPPLY CHARACTERISTICS**

Symbol	Parameter	Test Conditions	Тур.	Max.	Unit
IDDQ	Quiescent Power Supply Current	VDD = Max., OE/RST = LOW, SYNC = LOW, All outputs unloaded		1.5	mA
$\Delta I$ DD	Power Supply Current per Input HIGH	VDD = Max., VIN = 3.4V	0.4	1.5	mA
IDDD	Dynamic Power Supply Current (1)	VDD = Max., CL = 0pF	0.2	0.4	mA/MHz

### NOTE:

<sup>1.</sup> Operation in the specified SYNC frequency range guarantees that the VCO will operate in its optimal range of 20MHz to FMAX\_2xQ. Operation with Sync inputs outside specified frequency ranges may result in out-of-lock outputs. FREQ\_SEL only affects VCO frequency and does not affect output frequencies.

<sup>2.</sup> The lock output pin (LOCK) may not indicate reliably for VCO frequencies below 30MHz.

<sup>1.</sup> Relative to the frequency of Q outputs.

# **INPUT TIMING REQUIREMENTS**

Symbol	Description (1)	Min.	Max.	Unit
tr, tr	Maximum input rise and fall times, 0.8V to 2V	_	3	ns
Fı	Input Clock Frequency, SYNCo, SYNC1 (1)	2.5	FMAX _2XQ	MHz
tpwc	Input clock pulse, HIGH or LOW (2)	2	_	ns
Dн	Duty cycle, SYNCo, SYNC1 (2)	25	75	%

#### NOTES:

- See Output Frequency and Frequency Selection tables for more detail on allowable SYNC input frequencies for different speed grades with different FEEDBACK and FREQ\_SEL combinations.
- 2. Where pulse witdh implied by DH is less than twpc limit, twpc limit applies

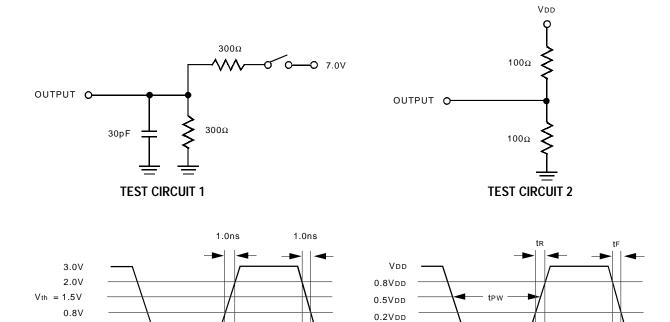
# **SWITCHING CHARACTERISTICS OVER OPERATING RANGE**

Symbol	Parameter (1)	Min.	Max.	Unit
tskr	Output Skew Between Rising Edges, Qo-Q4 and Q/2 (2)	_	500	ps
tskf	Output Skew Between Falling Edges, Qo-Q4 and Q/2 (2)	_	500	ps
tskall	Output Skew, All Outputs (2,5)	_	750	ps
tpw	Pulse Width, 2xQ output, >40MHz	Tcy/2 - 0.4	Tcy/2 + 0.4	ns
tpw	Pulse Width, Qo-Q4, Q5, Q/2 outputs, 80MHz	Tcy/2 - 0.4	Tcy/2 + 0.4	ns
tı	Cycle-to-Cycle Jitter (4)	- 0.15	0.15	ns
tpD	SYNC Input to Feedback Delay (6)	- 500	0	ps
tlock	SYNC to Phase Lock	_	10	ms
tрzн	Output Enable Time, OE/RST LOW to HIGH (3)	0	14	ns
tpzl				
tphz	Output Disable Time, OE/RST HIGH to LOW (3)	0	14	ns
tplz				
tr, tf	Output Rise/Fall Times, 0.2Vdd ~ 0.8Vdd	0.3	2.5	ns

#### NOTES:

- 1. See Test Loads and Waveforms for test load and termination.
- 2. Skew specifications apply under identical environments (loading, temperature, VDD, device speed grade).
- 3. Measured in open loop mode PLL\_EN = 0.
- 4. Jitter is characterized with Q output at 20MHz. See Frequency Selection Table for information on proper FREQ\_SEL level for specified input frequencies.
- 5. Skew measured at selected synchronization edge.
- 6. tpD measured at device inputs at 1.5V, Q output at 80MHz.

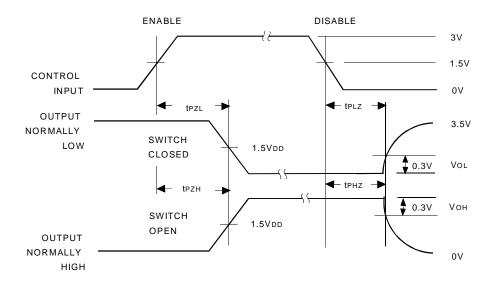
# **AC TEST LOADS AND WAVEFORMS**



### TTL INPUT TEST WAVEFORM

0 V

### **CMOS OUTPUT WAVEFORM**

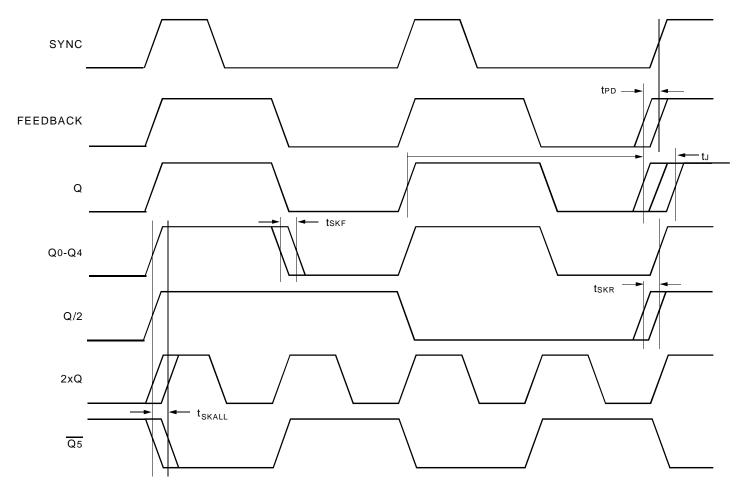


0 V

#### **ENABLE AND DISABLE TIMES**

TEST CIRCUIT 1 is used for output enable/disable parameters. TEST CIRCUIT 2 is used for all other timing parameters.

# **AC TIMING DIAGRAM**



#### NOTES:

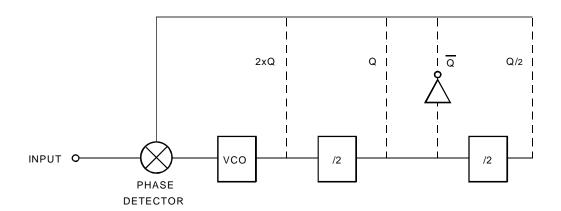
- 1. AC Timing Diagram applies to Q output connected to FEEDBACK and  $\overline{PE} = \text{GND}$ . For  $\overline{PE} = \text{VDD}$ , the negative edge of FEEDBACK aligns with the negative edge of SYNC input, and the negative edges of the multiplied and divided outputs align with the negative edge of SYNC.
- 2. All parameters except tPD are measured at 0.5VDD; tPD is measured at 1.5V.

## PLL OPERATION

The Phase Locked Loop (PLL) circuit included in the QS5919 provides for replication of incoming SYNC clock signals. Any manipulation of that signal, such as frequency multiplying or inversion is performed by digital logic following the PLL (see the block diagram). The key advantage of the

PLL circuit is to provide an effective zero propagation delay between the output and input signals. In fact, adding delay circuits in the feedback path, 'propagation delay' can even be negative! A simplified schematic of the QS5919 PLL circuit is shown below.

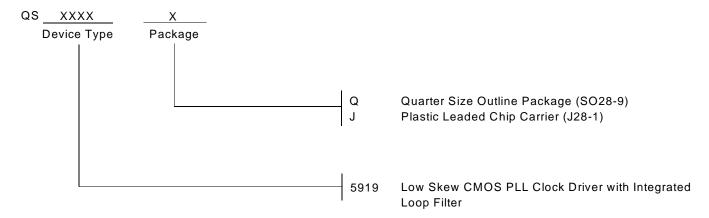
# SIMPLIFIED DIAGRAM OF QS5919 FEEDBACK



The phase difference between the output and the input frequencies feeds the VCO which drives the outputs. Whichever output is fed back, it will stabilize at the same frequency as the input. Hence, this is a true negative feedback closed loop system. In most applications, the output will optimally have zero phase shift with respect to the input. In fact, the internal loop filter on the QS5919 typically provides within 150ps of phase shift between input and output.

If the user wishes to vary the phase difference (typically to compensate for backplane delays), this is most easily accomplished by adding delay circuits to the feedback path. The respective output used for feedback will be advanced by the amount of delay in the feedback path. All other outputs will retain their proper relationships to that output.

# ORDERING INFORMATION





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